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Form PTO 1449 (Modified)		U.S. DEPARTMENT PATENT AND TRA	OF COMMERCE DEMARK OFFICE	260087US0PCT	SERIAL NO. 5 1 1 0 9 9 New U.S. PCT Application Based on PCT/JP03/04760			
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LIST OF	REFE	RENCES CITED BY AF	PLICANT	Masanori SERA, et al.				
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				U.S. PATENT DOCUMENTS		•		·
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				JP(English obstract and computer generated		YE	<u>s</u>	NO
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	AP	00/46254	08/10/00	WO(Equivalent of EP 4085025)		ļ		NO
	AQ	4-297415						NO
	AR	10-316711	12/02/98	JP(English abstract and computer gentranslation only)	erated			NO
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